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Communication from European Patent Office enclosing European search report under Rule 46(1) EPC

Application No. 03015517.0-2122

Examiner Date Considered 11-3-0

<sup>\*</sup> English language translation of the Abstract is enclosed.

Examiner: Initial citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not conformance and not considered. Include copy of this form with next communication to applicant. NY02:466996.1

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